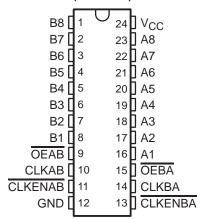
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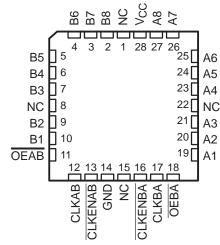
- Support Mixed-Mode Signal Operation (5-V Input and Output Voltages With 3.3-V V<sub>CC</sub>)
- Support Unregulated Battery Operation Down to 2.7 V
- Typical V<sub>OLP</sub> (Output Ground Bounce)
  <0.8 V at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C
- I<sub>off</sub> and Power-Up 3-State Support Hot Insertion

SN54LVTH2952...JT PACKAGE SN74LVTH2952...DB, DGV, DW, NS, OR PW PACKAGE (TOP VIEW)



- Bus-Hold on Data Inputs Eliminates the Need for External Pullup/Pulldown Resistors
- Latch-Up Performance Exceeds 500 mA Per JESD 17
- ESD Protection Exceeds JESD 22
  - 2000-V Human-Body Model (A114-A)
  - 200-V Machine Model (A115-A)

# SN54LVTH2952 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

#### description/ordering information

These octal bus transceivers and registers are designed specifically for low-voltage (3.3-V)  $V_{CC}$  operation, but with the capability to provide a TTL interface to a 5-V system environment.

#### ORDERING INFORMATION

TA	PACKA	GE†	ORDERABLE PART NUMBER	TOP-SIDE MARKING
	0010 014	Tube	SN74LVTH2952DW	11/71/0050
	SOIC - DW	Tape and reel	SN74LVTH2952DWR	LVTH2952
	SOP - NS	Tape and reel	SN74LVTH2952NSR	LVTH2952
-40°C to 85°C	SSOP – DB	Tape and reel	SN74LVTH2952DBR	LK952
	TOOOD DW	Tube	SN74LVTH2952PW	11/050
	TSSOP - PW	Tape and reel	SN74LVTH2952PWR	LK952
	TVSOP - DGV	Tape and reel	SN74LVTH2952DGVR	LK952
5500 to 40500	CDIP – JT	Tube	SNJ54LVTH2952JT	SNJ54LVTH2952JT
-55°C to 125°C	LCCC - FK	Tube	SNJ54LVTH2952FK	SNJ54LVTH2952FK

<sup>†</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



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#### description/ordering information

The 'LVTH2952 devices consist of two 8-bit back-to-back registers that store data flowing in both directions between two bidirectional buses. Data on the A or B bus is stored in the registers on the low-to-high transition of the clock (CLKAB or CLKBA) input, provided that the clock-enable (CLKENAB or CLKENBA) input is low. Taking the output-enable (OEAB or OEBA) input low accesses the data on either port.

Active bus-hold circuitry is provided to hold unused or floating data inputs at a valid logic level. Use of pullup or pulldown resistors with the bus-hold circuitry is not recommended.

When  $V_{CC}$  is between 0 and 1.5 V, the devices are in the high-impedance state during power up or power down. However, to ensure the high-impedance state above 1.5 V,  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

These devices are fully specified for hot-insertion applications using  $I_{off}$  and power-up 3-state. The  $I_{off}$  circuitry disables the outputs, preventing damaging current backflow through the devices when they are powered down. The power-up 3-state circuitry places the outputs in the high-impedance state during power up and power down, which prevents driver conflict.

#### **FUNCTION TABLE**†

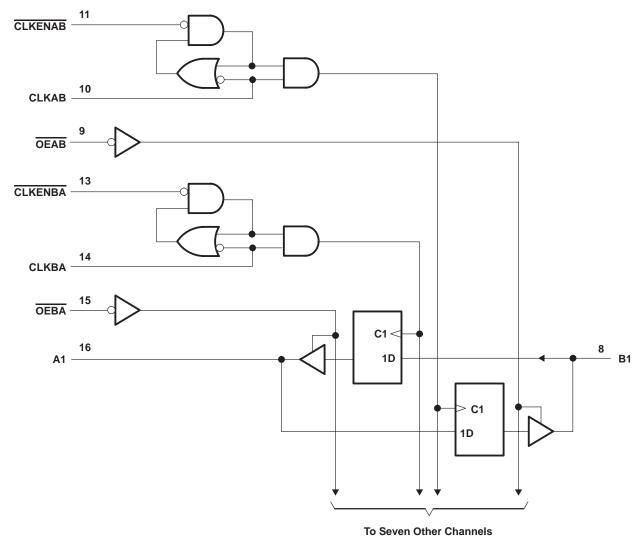
	INPUT	S		OUTPUT						
CLKENAB	CLKENAB CLKAB OEAB A									
Н	Х	L	Χ	в <sub>0</sub> ‡						
Х	H or L	L	Χ	в <sub>0</sub> ‡ в <sub>0</sub> ‡						
L	$\uparrow$	L	L	L						
L	$\uparrow$	L	Н	Н						
Х	X	Н	X	Z						

<sup>†</sup> A-to-B data flow is shown; B-to-A data flow is similar, but uses CLKENBA, CLKBA, and OEBA.



<sup>&</sup>lt;sup>‡</sup>Level of B before the indicated steady-state input conditions were established

# logic diagram (positive logic)



Pin numbers shown are for the DB, DGV, DW, JT, NS, and PW packages.

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# absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V <sub>CC</sub>	
Input voltage range, V <sub>I</sub> (see Note 1)	0.5 V to 7 V
Voltage range applied to any output in the high-impedance or power-off state, V <sub>O</sub> (see Note 1)	–0.5 V to 7 V
Voltage range applied to any output in the high state, V <sub>O</sub> (see Note 1)	0.5 V to $V_{CC}$ + 0.5 V
Current into any output in the low state, IO: SN54LVTH2952	96 mA
SN74LVTH2952	128 mA
Current into any output in the high state, IO (see Note 2): SN54LVTH2952	48 mA
SN74LVTH2952	64 mA
Input clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0)	
Output clamp current, $I_{OK}$ ( $V_O < 0$ )	
Package thermal impedance, θ <sub>JA</sub> (see Note 3): DB package	
	86°C/W
	46°C/W
	65°C/W
	88°C/W
Storage temperature range, T <sub>stg</sub>	

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
  - 2. This current flows only when the output is in the high state and  $V_O > V_{CC}$ .
  - 3. The package thermal impedance is calculated in accordance with JESD 51-7.

#### recommended operating conditions (see Note 4)

			SN54LVT	H2952	SN74LVT	H2952	
			MIN	MAX	MIN	MAX	UNIT
VCC	Supply voltage		2.7	3.6	2.7	3.6	V
V <sub>IH</sub>	High-level input voltage		2	3	2		V
V <sub>IL</sub>	Low-level input voltage			0.8		8.0	V
VI	Input voltage		4	5.5		5.5	V
loh	High-level output current		1	-24		-32	mA
loL	Low-level output current		2	48		64	mA
Δt/Δν	Input transition rise or fall rate	Outputs enabled	20/	10		10	ns/V
Δt/ΔV <sub>CC</sub>	Power-up ramp rate		200		200		μs/V
T <sub>A</sub>	Operating free-air temperature		-55	125	-40	85	°C

NOTE 4: All unused control inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

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# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

				SN5	4LVTH2	952	SN7	4LVTH2	952	
PAR	AMETER	TEST CO	ONDITIONS	MIN	TYP†	MAX	MIN	TYP†	MAX	UNIT
VIK		$V_{CC} = 2.7 \text{ V},$	I <sub>I</sub> = -18 mA			-1.2			-1.2	V
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V},$	I <sub>OH</sub> = -100 μA	VCC-0	.2		VCC-0	.2		
V		$V_{CC} = 2.7 \text{ V},$	I <sub>OH</sub> = -8 mA	2.4			2.4			V
VOH		V 2 V	I <sub>OH</sub> = -24 mA	2						V
		V <sub>CC</sub> = 3 V	I <sub>OH</sub> = -32 mA				2			
		V 07V	$I_{OL} = 100  \mu A$			0.2			0.2	
		V <sub>CC</sub> = 2.7 V	$I_{OL} = 24 \text{ mA}$			0.5			0.5	
\/ - ·			I <sub>OL</sub> = 16 mA			0.4			0.4	V
VOL		\\ 2\\	$I_{OL} = 32 \text{ mA}$			0.5			0.5	V
		V <sub>CC</sub> = 3 V	$I_{OL} = 48 \text{ mA}$			0.55				
			$I_{OL} = 64 \text{ mA}$						0.55	
	Control in nexts	$V_{CC} = 3.6 \text{ V},$	$V_I = V_{CC}$ or GND			±1			±1	
	Control inputs	$V_{CC} = 0 \text{ or } 3.6 \text{ V},$	V <sub>I</sub> = 5.5 V		À	10			10	
Ц			V <sub>I</sub> = 5.5 V	20					μΑ	
	A or B ports‡	V <sub>CC</sub> = 3.6 V	VI = VCC		5	1			1	
			V <sub>I</sub> = 0	-5			-5			
l <sub>off</sub>		$V_{CC} = 0$ ,	$V_I$ or $V_O = 0$ to 4.5 $V$	0					±100	μΑ
		\\ 2\\	V <sub>I</sub> = 0.8 V	75			75			
l <sub>l</sub> (hold)	A or B ports	V <sub>CC</sub> = 3 V	V <sub>I</sub> = 2 V	-75			-75			μА
		V <sub>CC</sub> = 3.6 √§,	$V_{I} = 0 \text{ to } 3.6 \text{ V}$						±500	
lozpu		$\frac{V_{CC}}{OE} = 0$ to 1.5 V, $V_{O} = \frac{V_{CC}}{OE} = 0$ don't care	0.5 V to 3 V,			±100*			±100	μА
lozpd		$\frac{V_{CC}}{OE}$ = 1.5 V to 0, $V_{O}$ = $\frac{V_{CC}}{OE}$ = don't care	0.5 V to 3 V,			±100*			±100	μΑ
		V <sub>CC</sub> = 3.6 V,	Outputs high			0.19			0.19	
ICC		$I_{O} = 0$ ,	Outputs low			5			5	mA
		$V_I = V_{CC}$ or GND	Outputs disabled		0.19 0.		0.19	<u> </u>		
ΔI <sub>CC</sub> ¶	V <sub>CC</sub> = 3 V to 3.6 V, Or Other inputs at V <sub>CC</sub> or					0.2			0.2	mA
Ci		V <sub>I</sub> = 3 V or 0			4			4		pF
C <sub>io</sub>		V <sub>O</sub> = 3 V or 0			9			9		pF

<sup>\*</sup> On products compliant to MIL-PRF-38535, this parameter is not production tested.

<sup>&</sup>lt;sup>†</sup> All typical values are at  $V_{CC}$  = 3.3 V,  $T_A$  = 25°C.

<sup>‡</sup> Unused terminals at V<sub>CC</sub> or GND

<sup>§</sup> This is the bus-hold maximum dynamic current. It is the minimum overdrive current required to switch the input from one state to another.

<sup>¶</sup>This is the increase in supply current for each input that is at the specified TTL voltage level, rather than V<sub>CC</sub> or GND.

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# timing requirement over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

				:	SN54LV	TH2952		;	SN74LV	TH2952		
				V <sub>CC</sub> =		VCC =	2.7 V	V <sub>CC</sub> =		VCC =	2.7 V	UNIT
				MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
fclock	Clock frequenc	у			150		150		150		150	MHz
	Dula a dunation		CLK high	3.3		3.3		3.3		3.3		
t <sub>w</sub>	Pulse duration	CLK low	3.3		3.3		3.3		3.3		ns	
		A B b - ( OLIC)	Data high	1.6		2.2		1.5		2.1		
	Catum tima	A or B before CLK↑	Data low	1.6	6	2.2		1.5		2.1		
t <sub>su</sub>	Setup time	CE before CLK↑	Data high	1.6	3	1.9		1.5		1.8		ns
		CE before CLK	Data low	2	000	2.6		1.9		2.5		
4.	I la lal tima a	A or B after CLK↑		1	Q.	0.2		1		0.2		20
th	Hold time CE after CLK↑			1.2		0.2		1.2		0.2		ns

# switching characteristics over recommended operating free-air temperature range, $C_L = 50 \text{ pF}$ (unless otherwise noted) (see Figure 1)

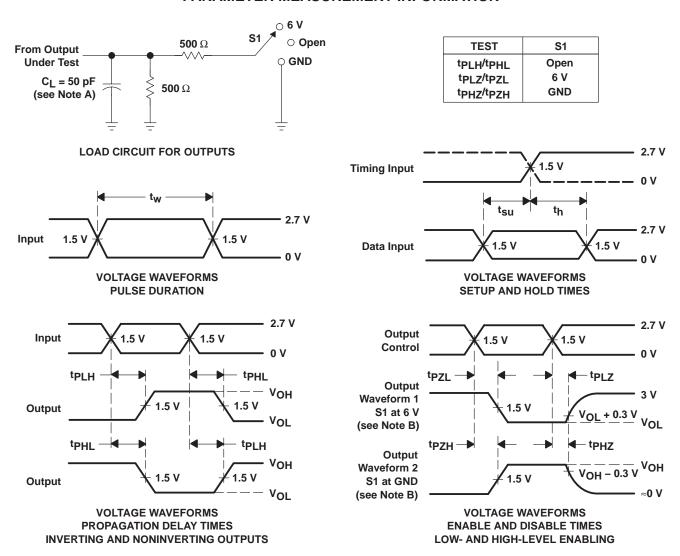
				SN54LV	TH2952			SN7	4LVTH2	952		
PARAMETER	FROM (INPUT)	TO (OUTPUT)		V <sub>CC</sub> = 3.3 V ± 0.3 V		V <sub>CC</sub> = 2.7 V		V <sub>CC</sub> = 3.3 V ± 0.3 V			V <sub>CC</sub> = 2.7 V	
			MIN	MAX	MIN	MAX	MIN	TYP†	MAX	MIN	MAX	
f <sub>max</sub>			150		150		150			150		MHz
<sup>t</sup> PLH	CLKBA or	A D	1.2	4.8	7//	5.5	1.3	2.9	4.6		5.3	
<sup>t</sup> PHL	CLKAB	A or B	1.2	4.8	A.	5.5	1.3	3.1	4.6		5.3	ns
<sup>t</sup> PZH	OEBA or OEAB	A or B	1	4.8	1	5.9	1.1	2.6	4.6		5.8	20
t <sub>PZL</sub>	OEBA OI OEAB	AUIB	1	4.8		5.9	1.1	3	4.6		5.8	ns
<sup>t</sup> PHZ	OEBA or OEAB	A or B	1.2	5.6		6	1.3	3.6	5.4		5.9	ne
t <sub>PLZ</sub>	OEDA UI OEAB		1.5	5.4		5.6	1.6	3.6	5.1		5.3	ns

<sup>&</sup>lt;sup>†</sup> All typical values are at  $T_A = 25$ °C.



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#### PARAMETER MEASUREMENT INFORMATION



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O$  = 50  $\Omega$ ,  $t_f \leq$  2.5 ns,  $t_f \leq$  2.5 ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E. All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuit and Voltage Waveforms



### PACKAGE OPTION ADDENDUM

17-Mar-2017

#### **PACKAGING INFORMATION**

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Orderable Device	Status	Package Type	_	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
SN74LVTH2952DW	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVTH2952	Samples
SN74LVTH2952PW	ACTIVE	TSSOP	PW	24	60	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LK952	Samples
SN74LVTH2952PWR	ACTIVE	TSSOP	PW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LK952	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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### PACKAGE OPTION ADDENDUM

17-Mar-2017

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# PACKAGE MATERIALS INFORMATION

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### TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74LVTH2952PWR	TSSOP	PW	24	2000	330.0	16.4	6.95	8.3	1.6	8.0	16.0	Q1

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#### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
SN74LVTH2952PWR	TSSOP	PW	24	2000	367.0	367.0	38.0	

DW (R-PDSO-G24)

# PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-013 variation AD.



DW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Refer to IPC7351 for alternate board design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



PW (R-PDSO-G24)

### PLASTIC SMALL OUTLINE



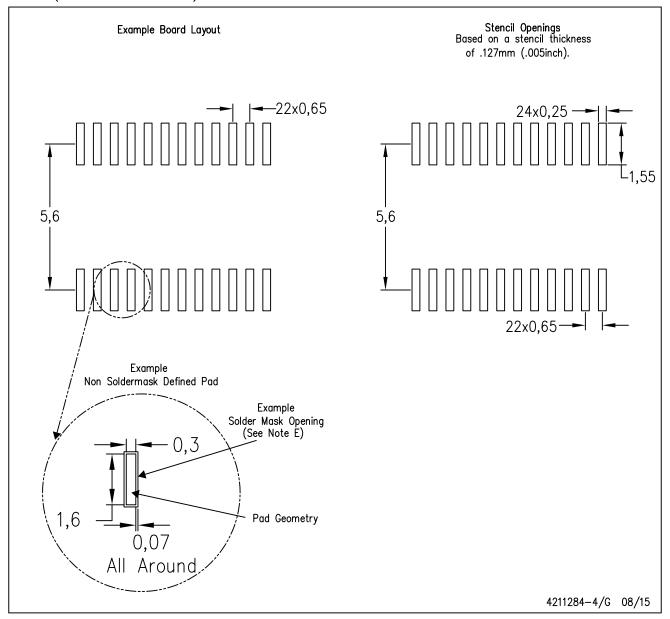
NOTES:

- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



# PW (R-PDSO-G24)

# PLASTIC SMALL OUTLINE



NOTES:

- All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.C. Publication IPC-7351 is recommended for alternate design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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